

A. Throughput Versus Power

In figure 2 the throughput versus power for each azimuth rotation is shown:

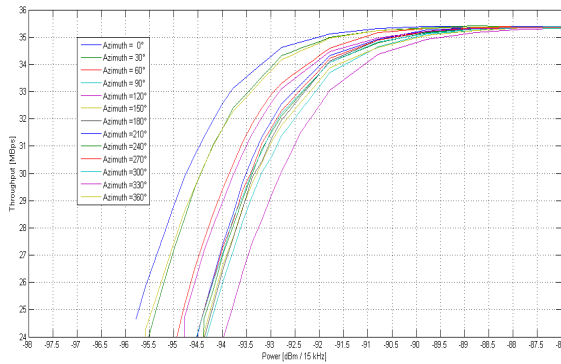


Fig. 2. Throughput Vs power for each azimuth rotation

The average throughput has been then calculated and in figure 3 the average throughput versus power is reported for both the mechanical modes tested, Portrait and Landscape:

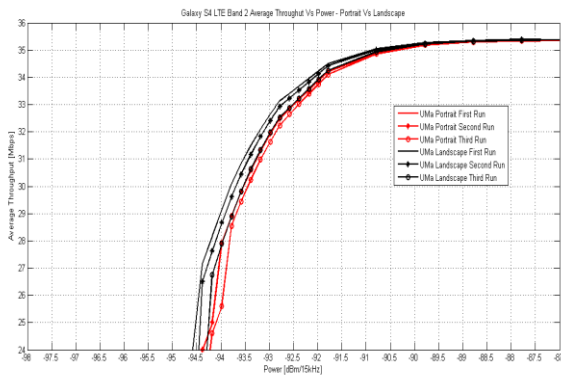


Fig. 3. Average Throughput Vs power – Portrait Vs Landscape

B. Throughput Versus SIR

Omni directional (AWGN) noise has been added to the LTE signal power. The noise can be added to each output of the fading emulators so that a specific Signal to Interference ratio (SIR) can be emulated at the DUT location. In Figure 4 the average throughput versus SIR is shown for both the mechanical modes:

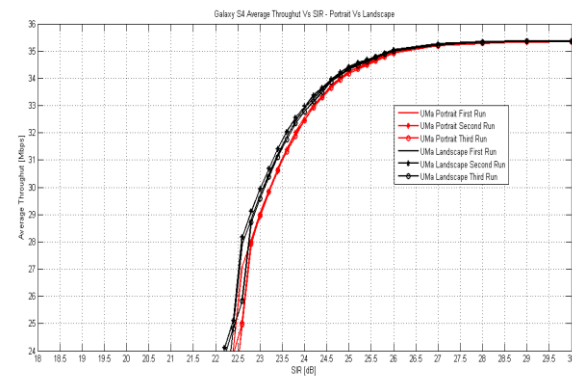


Fig. 4. Average Throughput Vs SIR – Portrait Vs Landscape

C. Device Performance Versus Azimuth Rotation

Effective Throughput Power Sensitivity (ETPS) is defined as the power [dBm/15kHz] required to achieve either the 95% or 70% of the maximum throughput for each azimuth rotation. ETPS Vs DUT rotation can indicate the degree of uniformity of the DUT MIMO performances as a function of the azimuth rotation. The same assumption is valid when SIR is considered. In figure 5, and 6 the device performance respectively in terms of power and SIR versus azimuth rotation are reported for the Portrait mechanical mode:

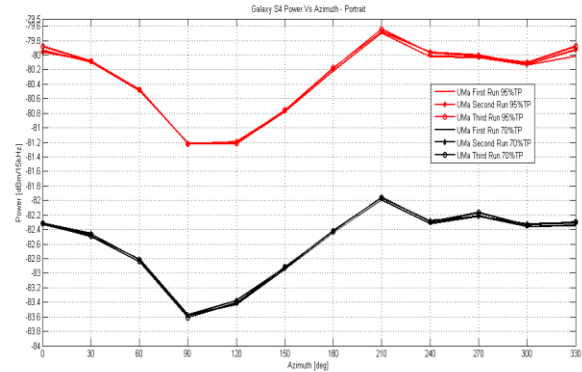


Fig. 5. Power Vs Azimuth rotation

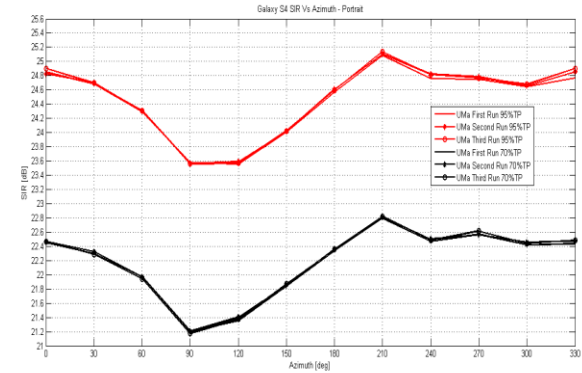


Fig. 6. SIR Vs Azimuth rotation

IV. CONCLUSION

2x2 MIMO Downlink OTA test results have been shown. The CTIA guidelines were used for measuring three LTE reference devices. The DUT MIMO performances in terms of throughput have been also reported in a way that the uniformity of the DUT versus azimuth rotation is shown.

REFERENCES

- [1] Draft CTIA Test Plan 2x2 MIMO Downlink and Transmit Diversity OTA Performances v 0.3, October 2014.
- [2] 3GPP TR. 37.977 v 13.0, November 2013.
- [3] A.Scannavini, L.J.Foged, et.al., “OTA Throughput Measurement by using the Spatial Fading Emulation Technique” EuCap2010.
- [4] A.Scannavini, L.J.Foged, et.al., “MIMO OTA Testing using Multi Probe System Approach”, EuCap2013.
- [5] A.Scannavini, L.J.Foged, et.al., “OTA Measurement of Wireless Devices with Single and Multiple Antennas in Anecdot Chamber”, EuCap2014.